

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/786,372	ZHENG ET AL.	
Examiner	Art Unit	
Dawn Garrett	1774	

SEARCHED					
Class	Subclass	Date	Examiner		
428	690	7/31/2005	Dej		
428	917				
313	504				
813	506				
257	40				
427	46				
252	301.16	$\overline{\mathbf{V}}$			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST SEARCH Databases: JPO EPO DERWENT USPGPUB'USPAT Text, classification and classification limited by text searching Siel pointout	7/31/2005	DH.		
STIC search report attached	4/22/2005	94		
STIC search report attached	6/24/2005	9y		
Inventor name search: PALM, EAST, eDAN	7/2005	Dy		
EAST search (see purifout)	1/9/06	St		
EAST search (see printont)	8/29/06	<i>9</i> \$		
STIC search (selprinitions)	8/2/06	ØJ		
SAC search (see printout)	3/26/07	Dy		

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